

Search Notes

Application/Control No.

10/654,222

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

SHIRAGAKI ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	216	4/13/2007	HN
	222		
	223		
	224		
	225		
	228		
	242		
	248		
	535		
	536		
	537		
398	1		
	3		
	43		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	4/13/2007	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	223	4/13/2007	HN
	535		